

10/052475  
01/17/02

U.S. UTILITY Patent Application

PATENT NUMBER and  
ISSUE DATE

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10052475	01/17/2002	451	296	3723	Thomas

APPLICANTS: Wang Yuchun; Frey Bernard; Basol Bulent;

\*\*CONTINUING DATA VERIFIED: DBT

THIS APPLICATION IS A CIP OF 09/684,059 10/06/2000 PAT 6,468,139  
WHICH IS A CIP OF 09/576,064 05/22/2000 PAT 6,207,572  
WHICH IS A CON OF 09/201,928 12/01/1998 PAT 6,103,628

\*\* FOREIGN APPLICATIONS VERIFIED: DBT

PG-PUB DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed

☐ yes ☒ no

35 USC 119 conditions met

☐ yes ☒ no

Verified and Acknowledged Examiners's initials

ATTORNEY DOCKET NO

042496/0269274 NT-238(U)

TITLE : Chemical mechanical polishing endpoint detection

U.S. DEPT. OF COMM./PAT. & TM-PTO 4361 (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		DAVID B. THOMAS Assistant Examiner		CLAIMS ALLOWED	
11/13/14				Total Claims 29	Print Claim for O.G. 1
ISSUE FEE		Joseph J. Hail, III Supervisory Patent Examiner Technology Center 3700 Primary Examiner		DRAWING	
Amount Due 1335	Date Paid			Sheet Drawg. 3	Fig. Drawg. 5
		PREPARED FOR ISSUE		Print Fig. 2	
<input type="checkbox"/> TERMINAL DISCLAIMER		WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.		Application Examiner	

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